



**P-CHANNEL MOSFET**  
**Qualified per MIL-PRF-19500/564**

*Qualified Levels:*  
 JAN, JANTX, JANTXV  
 and JANS

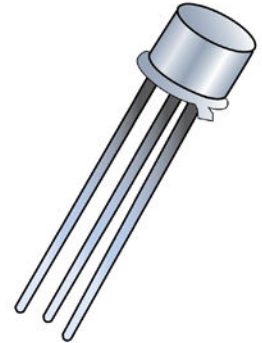
**DESCRIPTION**

This 2N6849 switching transistor is military qualified up to the JANS level for high-reliability applications. This device is also available in a low profile U surface mount package. Microsemi also offers numerous other transistor products to meet higher and lower power ratings with various switching speed requirements in both through-hole and surface-mount packages.

**Important:** For the latest information, visit our website <http://www.microsemi.com>.

**FEATURES**

- JEDEC registered 2N6849 number.
- JAN, JANTX, JANTXV and JANS qualifications are available per MIL-PRF-19500/564. (See [part nomenclature](#) for all available options.)
- RoHS compliant versions available (commercial grade only).



**TO-205AF (TO-39)  
 Package**

**APPLICATIONS / BENEFITS**

- Lightweight top-hat design with flexible terminals offers a variety of mounting flexibility.
- Military and other high-reliability applications.

Also available in:

**U-18 LCC package**  
 (surface mount)  
 [2N6849U](#)

**MAXIMUM RATINGS @ T<sub>A</sub> = +25°C unless otherwise stated**

Parameters / Test Conditions	Symbol	Value	Unit
Operating & Storage Junction Temperature Range	T <sub>J</sub> & T <sub>stg</sub>	-55 to +150	°C
Thermal Resistance Junction-to-Case	R <sub>θJC</sub>	5.0	°C/W
Total Power Dissipation	P <sub>T</sub>	0.8 25	W
		@ T <sub>A</sub> = +25 °C	
		@ T <sub>C</sub> = +25 °C <sup>(1)</sup>	
Drain-Source Voltage, dc	V <sub>DS</sub>	-100	V
Gate-Source Voltage, dc	V <sub>GS</sub>	± 20	V
Drain Current, dc @ T <sub>C</sub> = +25 °C <sup>(2)</sup>	I <sub>D1</sub>	-6.5	A
Drain Current, dc @ T <sub>C</sub> = +100 °C <sup>(2)</sup>	I <sub>D2</sub>	-4.1	A
Off-State Current (Peak Total Value) <sup>(3)</sup>	I <sub>DM</sub>	-25	A (pk)
Source Current	I <sub>S</sub>	-6.5	A

- Notes:**
1. Derate linearly 0.2 W/°C for T<sub>C</sub> > +25 °C.
  2. The following formula derives the maximum theoretical I<sub>D</sub> limit. I<sub>D</sub> is also limited by package and internal wires and may be limited due to pin diameter.

$$I_D = \sqrt{\frac{T_J(\text{max}) - T_C}{R_{\theta JC} \times R_{DS(on)} @ T_J(\text{max})}}$$

3. I<sub>DM</sub> = 4 × I<sub>D1</sub> as calculated in note 2.

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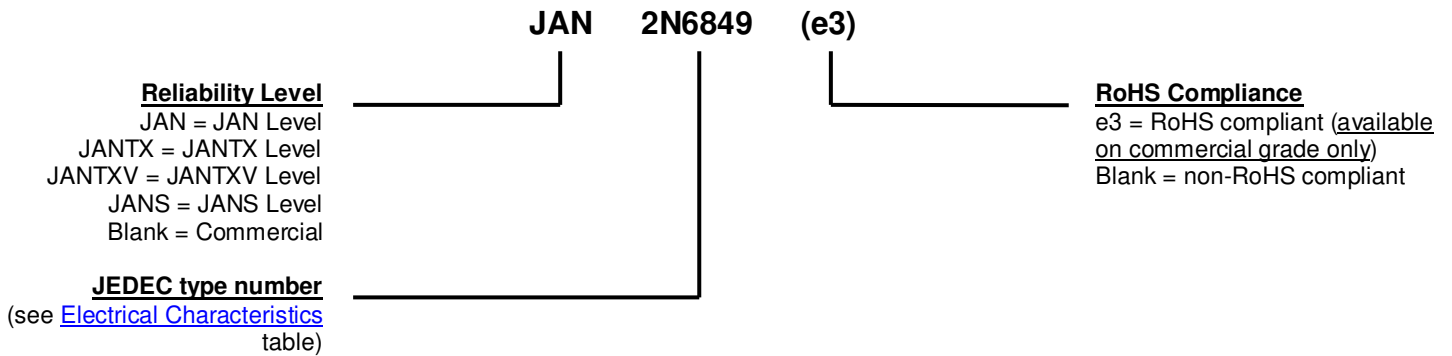
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**MECHANICAL and PACKAGING**

- CASE: Hermetically sealed, kovar base, nickel cap.
- TERMINALS: Tin/lead solder dip nickel plate or RoHS compliant pure tin plate (commercial grade only).
- MARKING: Part number, date code, manufacturer's ID.
- WEIGHT: Approximately 1.064 grams.
- See [Package Dimensions](#) on last page.

**PART NOMENCLATURE**

**SYMBOLS & DEFINITIONS**

Symbol	Definition
di/dt	Rate of change of diode current while in reverse-recovery mode, recorded as maximum value.
I <sub>F</sub>	Forward current
R <sub>G</sub>	Gate drive impedance
V <sub>DD</sub>	Drain supply voltage
V <sub>DS</sub>	Drain source voltage, dc
V <sub>GS</sub>	Gate source voltage, dc

**ELECTRICAL CHARACTERISTICS @  $T_A = +25\text{ }^\circ\text{C}$ , unless otherwise noted**

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
<b>OFF CHARACTERISTICS</b>				
Drain-Source Breakdown Voltage $V_{GS} = 0\text{ V}$ , $I_D = -1.0\text{ mA}$	$V_{(BR)DSS}$	-100		V
Gate-Source Voltage (Threshold) $V_{DS} \geq V_{GS}$ , $I_D = -0.25\text{ mA}$ $V_{DS} \geq V_{GS}$ , $I_D = -0.25\text{ mA}$ , $T_J = +125\text{ }^\circ\text{C}$ $V_{DS} \geq V_{GS}$ , $I_D = -0.25\text{ mA}$ , $T_J = -55\text{ }^\circ\text{C}$	$V_{GS(th)1}$ $V_{GS(th)2}$ $V_{GS(th)3}$	-2.0 -1.0	-4.0 -5.0	V
Gate Current $V_{GS} = \pm 20\text{ V}$ , $V_{DS} = 0\text{ V}$ $V_{GS} = \pm 20\text{ V}$ , $V_{DS} = 0\text{ V}$ , $T_J = +125\text{ }^\circ\text{C}$	$I_{GSS1}$ $I_{GSS2}$		$\pm 100$ $\pm 200$	nA
Drain Current $V_{GS} = 0\text{ V}$ , $V_{DS} = -80\text{ V}$	$I_{DSS1}$		-25	$\mu\text{A}$
Drain Current $V_{GS} = 0\text{ V}$ , $V_{DS} = -80\text{ V}$ , $T_J = +125\text{ }^\circ\text{C}$	$I_{DSS2}$		-0.25	mA
Static Drain-Source On-State Resistance $V_{GS} = -10\text{ V}$ , $I_D = -4.1\text{ A}$ pulsed	$r_{DS(on)1}$		0.30	$\Omega$
Static Drain-Source On-State Resistance $V_{GS} = -10\text{ V}$ , $I_D = -6.5\text{ A}$ pulsed	$r_{DS(on)2}$		0.32	$\Omega$
Static Drain-Source On-State Resistance $T_J = +125\text{ }^\circ\text{C}$ $V_{GS} = -10\text{ V}$ , $I_D = -4.1\text{ A}$ pulsed	$r_{DS(on)3}$		0.54	$\Omega$
Diode Forward Voltage $V_{GS} = 0\text{ V}$ , $I_D = -6.5\text{ A}$ pulsed	$V_{SD}$		-4.3	V

**DYNAMIC CHARACTERISTICS**

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
Gate Charge:				
On-State Gate Charge $V_{GS} = -10\text{ V}$ , $I_D = -6.5\text{ A}$ , $V_{DS} = -50\text{ V}$	$Q_{g(on)}$		34.8	nC
Gate to Source Charge $V_{GS} = -10\text{ V}$ , $I_D = -6.5\text{ A}$ , $V_{DS} = -50\text{ V}$	$Q_{gs}$		6.8	nC
Gate to Drain Charge $V_{GS} = -10\text{ V}$ , $I_D = -6.5\text{ A}$ , $V_{DS} = -50\text{ V}$	$Q_{gd}$		23.1	nC

**ELECTRICAL CHARACTERISTICS @  $T_A = +25\text{ }^\circ\text{C}$ , unless otherwise noted (continued)**
**SWITCHING CHARACTERISTICS**

<b>Parameters / Test Conditions</b>	<b>Symbol</b>	<b>Min.</b>	<b>Max.</b>	<b>Unit</b>
Turn-on delay time $I_D = -6.5\text{ A}$ , $V_{GS} = -10\text{ V}$ , $R_G = 7.5\ \Omega$ , $V_{DD} = -40\text{ V}$	$t_{d(on)}$		60	ns
Rinse time $I_D = -6.5\text{ A}$ , $V_{GS} = -10\text{ V}$ , $R_G = 7.5\ \Omega$ , $V_{DD} = -40\text{ V}$	$t_r$		140	ns
Turn-off delay time $I_D = -6.5\text{ A}$ , $V_{GS} = -10\text{ V}$ , $R_G = 7.5\ \Omega$ , $V_{DD} = -40\text{ V}$	$t_{d(off)}$		140	ns
Fall time $I_D = -6.5\text{ A}$ , $V_{GS} = -10\text{ V}$ , $R_G = 7.5\ \Omega$ , $V_{DD} = -40\text{ V}$	$t_f$		140	ns
Diode Reverse Recovery Time $di/dt \leq -100\text{ A}/\mu\text{s}$ , $V_{DD} \leq -50\text{ V}$ , $I_F = -6.5\text{ A}$	$t_{rr}$		250	ns

GRAPHS

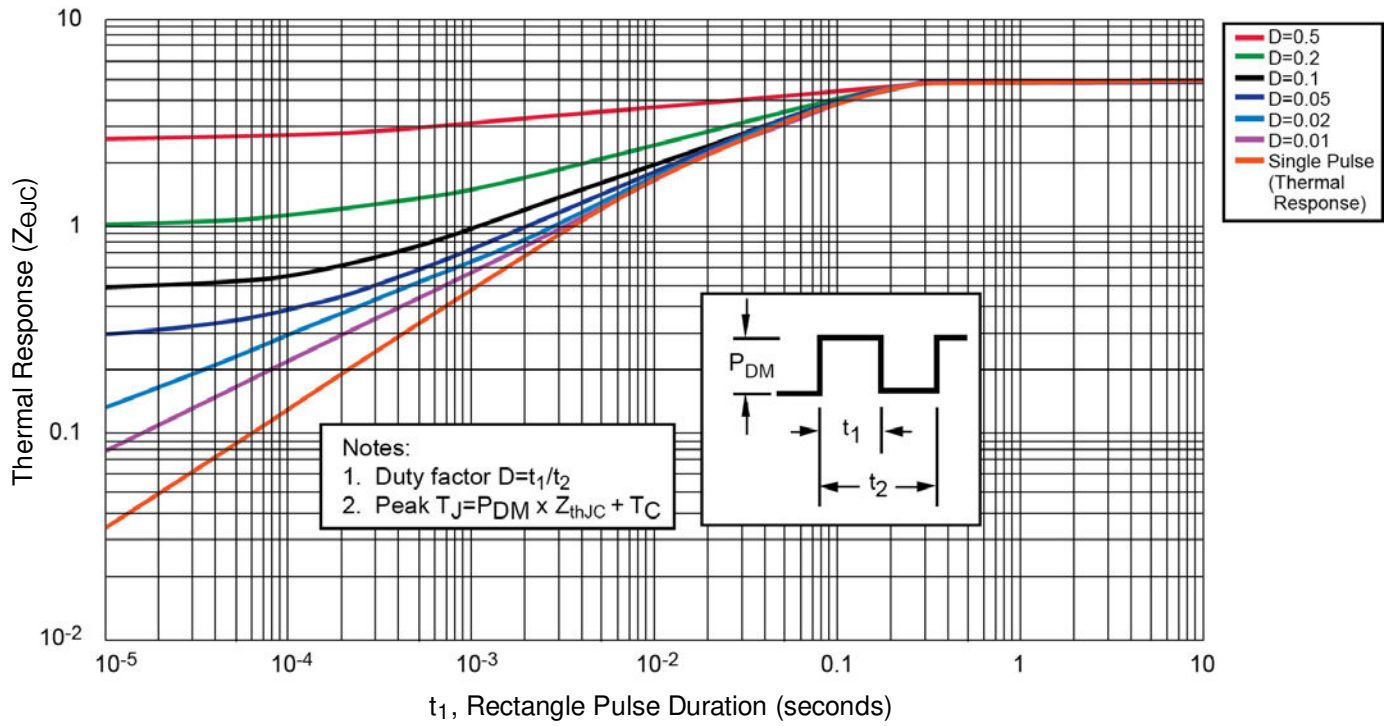


FIGURE 1 – Normalized Transient Thermal Impedance

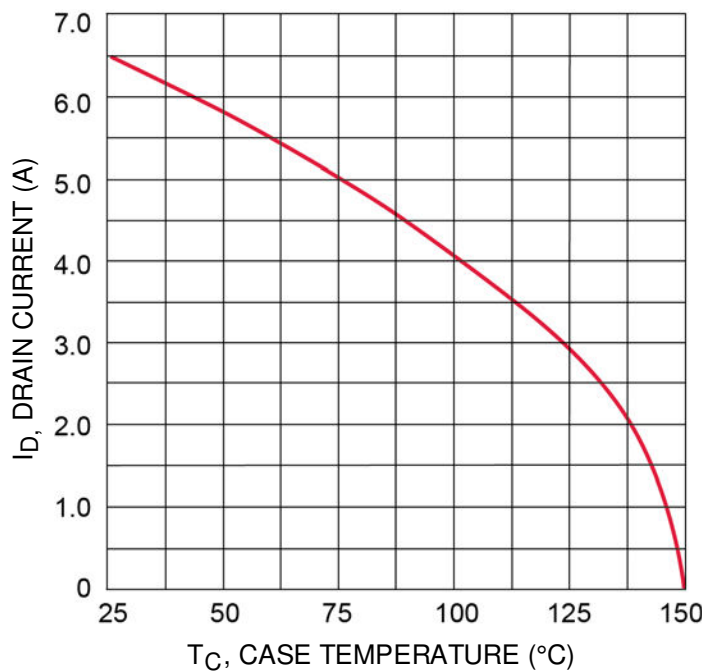
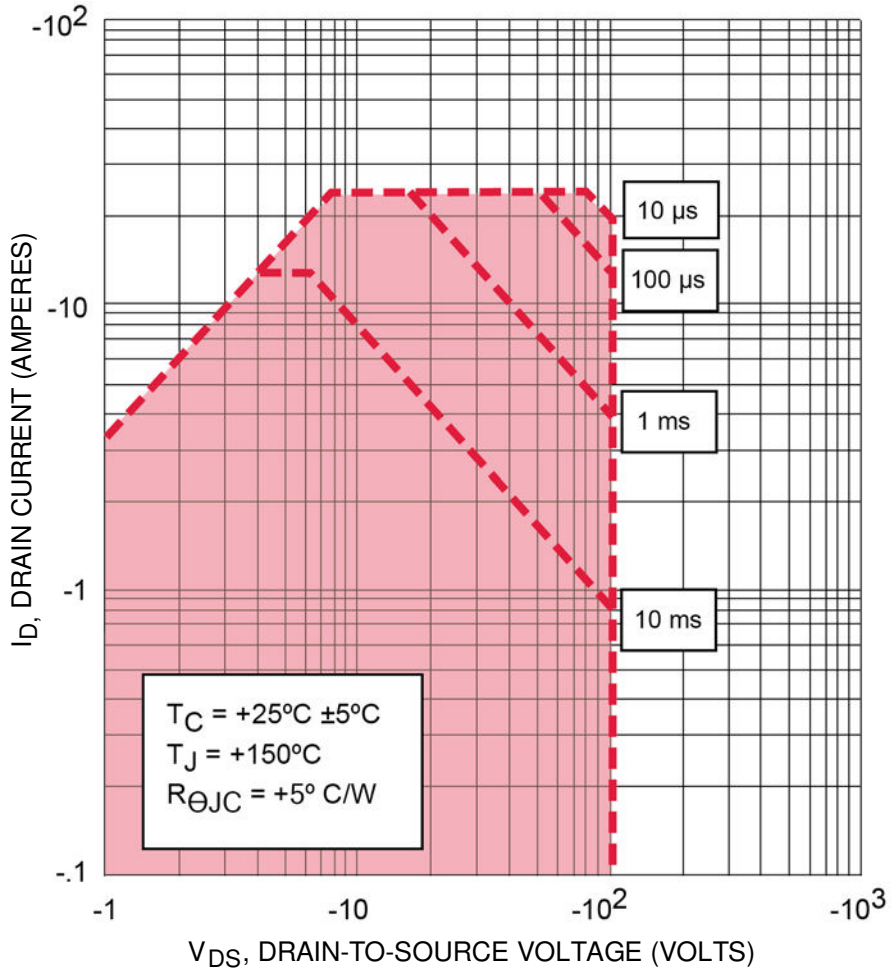
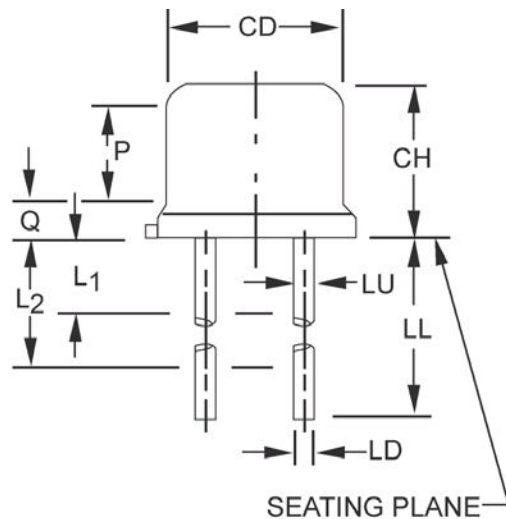


FIGURE 2 – Maximum Drain Current vs Case Temperature

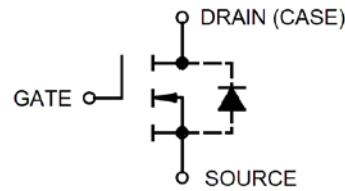
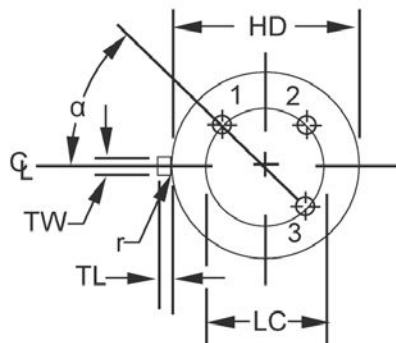
GRAPHS (continued)



**FIGURE 3 – Maximum Safe Operating Area**

**PACKAGE DIMENSIONS**


Symbol	Dimensions				Note
	Inch		Millimeters		
	Min	Max	Min	Max	
CD	0.305	0.335	7.75	8.51	
CH	0.160	0.180	4.07	4.57	
HD	0.335	0.370	8.51	9.39	
LC	0.200 TP		5.08 TP		6
LD	0.016	0.021	0.41	0.53	7, 8
LL	0.500	0.750	12.70	19.05	7, 8
LU	0.016	0.019	0.41	0.48	7, 8
L1	-	0.050	-	1.27	7, 8
L2	0.250	-	6.35	-	7, 8
P	0.100	-	2.54	-	5
Q	-	0.050	-	1.27	4
TL	0.029	0.045	0.74	1.14	3
TW	0.028	0.034	0.72	0.86	2
r	-	0.010	-	0.25	9
$\alpha$	45° TP		45° TP		6


**Schematic**
**NOTES:**

- Dimensions are in inches. Millimeters are given for general information only.
- Beyond radius (r) maximum, TW shall be held for a minimum length of 0.011 (0.028 mm).
- Dimension TL measured from maximum HD.
- Outline in this zone is not controlled.
- Dimension CD shall not vary more than 0.010 (0.25 mm) in zone P. This zone is controlled for automatic handling.
- Leads at gauge plane 0.054 +0.001, -0.000 (1.37 +0.03, -0.00 mm) below seating plane shall be within 0.007 (0.18 mm) radius of true position (TP) at maximum material condition (MMC) relative to tab at MMC.
- LU applies between L1 and L2. LD applies between L2 and LL minimum. Diameter is uncontrolled in L1 and beyond LL minimum.
- All three leads.
- Radius (r) applies to both inside corners of tab.
- Drain is electrically connected to the case.
- In accordance with ASME Y14.5M, diameters are equivalent to  $\Phi$ x symbology.
- Lead 1 = source, lead 2 = gate, lead 3 = drain.